

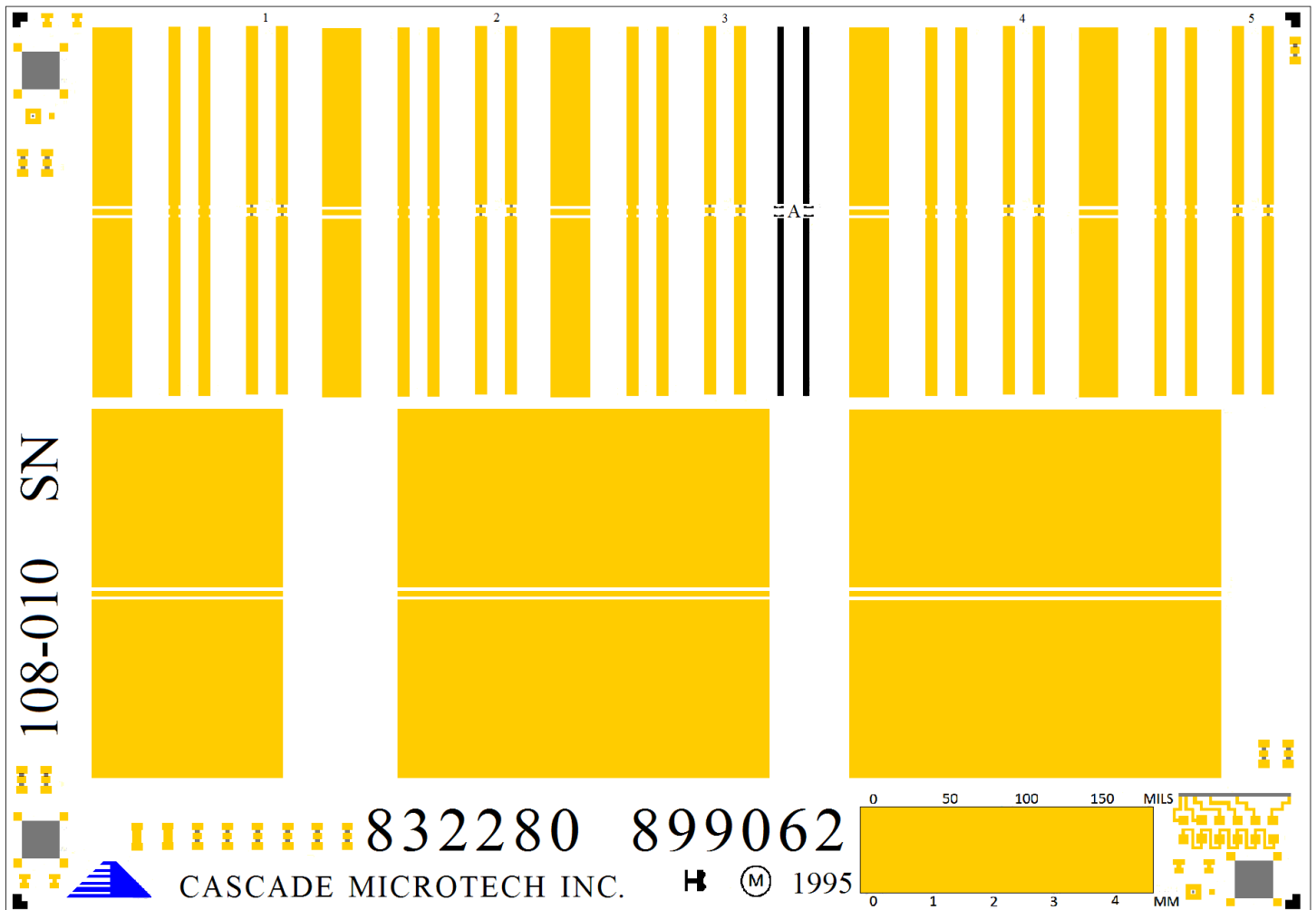
Cascade Impedance Standard Substrate Map

000111100010

► **P/N: 108-010**

Pitch: 150 μm - 3000 μm



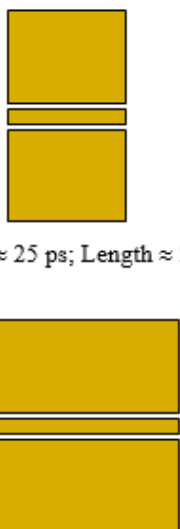
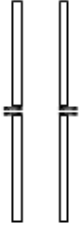
Configuration: **GSG**



> Key to Map

Key to the 108-010 Map

Substrate specifications: Material: Alumina; Thickness: 25 mils (635 μm); Dielectric constant: 9.9

 <p>Thru</p> <p>Short</p>	<p>Thru delay: 4 ps</p> <p>Impedance: Nominally 50 Ω</p>	 <p>Load</p> <p>Precision 50 Ω Load</p>	<p>For optimum calibration accuracy only the Red -marked load standards should be used</p> <p>DC accuracy: +/- 0.3 %</p> <p>Note: Ensure the bias supply is turned off during calibration. Applying bias to the probe during calibration could cause the resistance of the load to change</p>	<p>Verification Lines</p>  <p>Thru Delay \approx 25 ps; Length \approx 3150 μm</p> <p>Thru Delay \approx 50 ps; Length \approx 6150 μm</p>	 <p>A</p> <p>Alignment Marks</p> <p>Note: An Open is synthesized by raising the probes in air a minimum distance of 250 μm above the chuck surface</p>
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All of the above specifications are based on an overtravel (downward movement of probe after initial touchdown on the substrate) of 100-150 μm . This amount of overtravel can be set before calibration on the Impedance Standard Substrate (ISS) using the alignment marks (allows precise setting of probe separation and overtravel). Figure 1 shows that initial contact with the edge of the probe tips should be made at reference plane X (midpoint between the outer flat edge and the internal apex). The desired overtravel and thus skate (forward movement of probe tips after initial contact with substrate) is then achieved by adjusting the Z height on the positioner to move the edge of the probe tips to reference plane Y (midpoint between the internal apex and the flag points). This can also be seen from the photographic images shown in Figure 2.

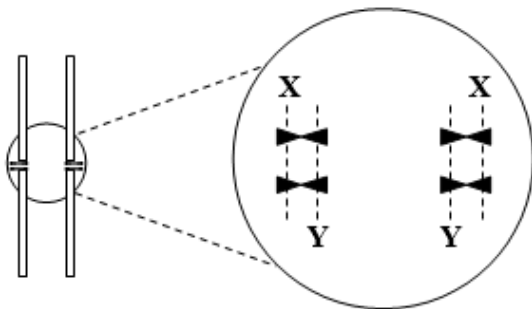


Figure 1: Alignment marks

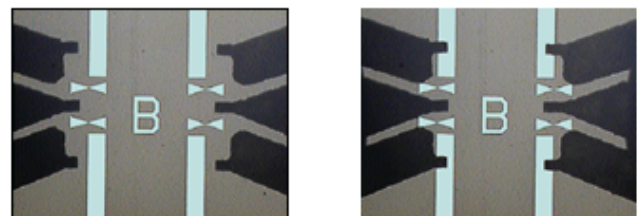


Figure 2: Images showing correct alignment and placement of probe tips

Calibration Coefficients are dependent on the probe tip configuration, placement on a standard, and the standard configurations. This leads to unique calibration coefficients for a unique pair of probe and ISS. Therefore, the calibration coefficients are supplied with the probe not with the ISS.

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